

**Issue Classification**

Application/Control No.

10774469

Applicant(s)/Patent Under Reexamination

LEE, HYEOK-BEOM

Examiner

Wang, Claire

Art Unit

2624

**ORIGINAL**

CLASS

SUBCLASS

382

103

**INTERNATIONAL CLASSIFICATION**

CLAIMED

NON-CLAIMED

G 0 6 K

9 / 00 (2006.01.01)

**CROSS REFERENCE(S)**

CLASS

SUBCLASS (ONE SUBCLASS PER BLOCK)

382

118

Wang, Claire

11/16/2007

(Assistant Examiner)

(Date)

Total Claims Allowed:

15

Shanell m  
(Legal Instruments  
Examiner)12-10-07  
(Date)

(Primary Examiner)

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O.G. Print Claim(s)

1

O.G. Print Figure

4